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Application/Control No.	Applicant(s)/Patent under Reexamination
09/929,367	YORINAGA ET AL.
Examiner	Art Unit

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SEARCHED			
Class	Subclass	Date	Examiner
370	235.1	2/27/2006	нм
370	229-236	2/27/2006	нм
370	396-399	2/27/2006	НМ
370	412-418	2/27/2006	нм
709	235	2/27/2006	нм

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Searched EAST DB:USPG-PUB, USPAT, EPO, and JPO	2/27/2006	НМ
IEEE	2/27/2006	НМ